

Notice of References Cited	Application/Control No. 10/804,368		Applicant(s)/Patent Under Reexamination INOUE, YUUKI	
	Examiner DENNIS DICKER		Art Unit 2625	Page 1 of 1

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*	B	US-2002/0163659	11-2002	Ohkubo, Akito	358/1.9
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